EPC7030MSH 300 V Radiation Hardened Power eGaN[®] Datasheet

Features

- Ultra-low Q_G For High Efficiency
- Logic Level
- Light Weight
- Compact Hermetic Package
 Dual Gate
- Source Sense Pin
- Total Ionizing Dose LDR Immune
- Total Ionizing Dose HDR Immune
- Single Event Effect (SEE) Hardened
 - SEE immunity for LET of 84.6 MeV/mg/cm² with V_{DS} up to 100% of rated Breakdown
- Neutron
 - Maintains Pre-Rad specification for up to 4 x 10¹⁵ Neutrons/cm²

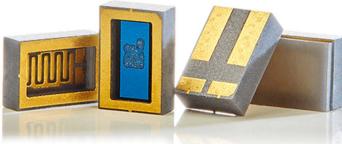
Applications

- Satellite and Avionics
- Deep Space Probes
- High Speed Rad-Hard DC-DC Conversion
- Rad-Hard Motor Controllers
- Nuclear Facilities

Thermal Characteristics

Symbol	Parameter-Conditions	Value	Units
$R_{\theta JA}$	Thermal Resistance Junction to Ambient (Note 3)	35	°C/W
$R_{ extsf{ heta}JC}$	Thermal Resistance Junction to Case	0.94	C/ VV





EPC7030MSH

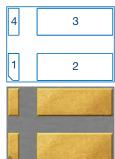
Rad-Hard eGaN[®] 300 V, 50 A, 35 m Ω Surface Mount (FSMD-M)

Description

EPC Space FSMD-M series of eGaN[®] power switching HEMTs have been specifically designed for critical applications in Space and other the high reliability environments. These devices have exceptionally high electron mobility and a low temperature coefficient resulting in very low $R_{DS(on)}$ values. The lateral structure of the die provides for very low gate charge (Q_G) and extremely fast switching times. These features enable faster power supply switching frequencies resulting in higher power densities, higher efficiencies and more compact packaging.

I/O Pin Assignment (Bottom View)

Pin	Symbol	Description
1	G	Gate
2	D	Drain
3	S	Source
4	SS	Source Sense



Absolute Maximum Rating ($T_c = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter-Conditions	Value	Units	
V	Drain to Source Voltage (Note 1)	300	V	
V _{DS}	Drain-to-Source Voltage (up to 10,000 5 ms pulses at 150°C)	360	V	
I _D	Continuous Drain Current ID @ $V_{GS} = 5 V$	50		
I _{DM}	Single-Pulse Drain Current t _{pulse} = 300 µs	150	A	
V _{GS}	Gate to Source Voltage (Note 2)	+6 / -4	V	
T_{J},T_{STG}	Operating and Storage Junction Temperature Range	-55 to +150	°C	
T _{SOL}	Package Mounting Surface Temperature	260	U	
ESD	ESD Class	1B (ΔB)		
Weight	Device Weight	0.190	g	

Static Characteristics (Typical (TYP) values are for reference only.)

Parameter	Symbol	Test Conditions		MIN	ΤΥΡ	MAX	Units
Drain to Source Voltage	B _{VDSS}	$V_{GS} = 0 V$		300			V
Ducia ta Caunaa Laakaara		$V_{DS} = 300 \text{ V}, V_{GS} = 0 \text{ V}$	$T_{\rm C} = 25^{\circ}{\rm C}$		11	400	-
Drain to Source Leakage	IDSS	$V_{DS} = 300 \text{ V}, V_{GS} = 0 \text{ V}$	T _C = 125°C		22	800	
Gate to Source Forward Leakage		V _{GS} = 6 V	$T_{\rm C} = 25^{\circ}{\rm C}$		0.4	600	μA
Gate to Source Forward Leakage	IGSSF	V _{GS} = 6 V	T _C = 125°C		1	1000	_
Gate to Source Reverse Leakage	I _{GSSR}	$V_{GS} = -4 V$	T _C = 25°C		5	0.5	
Gate to Source Threshold Voltage	V _{GS(th)}		$T_{\rm C} = 25^{\circ}{\rm C}$	0.8	1. 5	2.5	V
Gate to Source Threshold Voltage Temperature Coefficient	$\Delta V_{GS(th)}$	$V_{DS} = V_{GS}$, $I_D = 18$ mA	-55°C < T _A < 150°C		2.0		mV/°C
Drain to Source Resistance (Note 4)	R _{DS(on)}	$V_{GS} = 5 \text{ V}, \text{ I}_{D} = 50 \text{ A}$	$T_{\rm C} = 25^{\circ}{\rm C}$		15	35	mΩ
Source to Drain Forward Voltage	V _{SD}	I _S = 0.5 A, V _G = 0 V	$T_{\rm C} = 25^{\circ}{\rm C}$		1.7	3	V

Dynamic Characteristics ($T_c = 25^{\circ}C$ unless otherwise noted. Typical (TYP) values are for reference only.)

Parameter	Symbol	Test Conditions	MIN	ΤΥΡ	MAX	Units
Input Capacitance	C _{ISS}			1155		
Reverse transfer Capacitance	C _{RSS}	$V_{DS} = 150 \text{ V}, V_{GS} = 0 \text{ V}$		10		pF
Output Capacitance	C _{OSS}			235		
Effective Output Capacitance, Energy Related	C _{OSS(ER)}			970		
Effective Output Capacitance, Time Related	C _{OSS(TR)}	$V_{DS} = 0$ to 150 V, $V_{GS} = 0$ V		1250		
Total Gate Charge (Note 6)	Q _G	V _{DS} = 150 V, V _{GS} = 5 V,		25	30	
Gate to Source Charge (Note 6)	Q _{GS}	$I_{\rm D} = 50 {\rm A}$		8	10	
Gate to Drain Charge (Note 6)	Q _{GD}			4	7	nC
Output Charge (Note 5)	Q _{OSS}	$V_{DS} = 150 \text{ V}, V_{GS} = 0 \text{ V}$		147		
Source to Drain Recovery Charge (Note 5)	Q _{RR}			0		

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Radiation Characteristics

EPC Space eGaN[®] HEMTs are tested according to MIL-STD-750 Method 1019 for total ionizing dose validation. Every manufacturing lot is tested for total ionizing dose of 1 Mrad of Gamma radiation exposure with an in-situ bias for the following conditions:

 $\begin{array}{ll} \text{ON} & \mid V_{\text{GS}} = 5 \text{ V} \\ \text{NO BIAS} & \mid V_{\text{DS}} = V_{\text{GS}} = 0 \text{ V} \\ \text{OFF} & \mid V_{\text{DS}} = 80\% \text{ B}_{\text{VDSS}} \end{array}$

Electrical Characteristics up	to 1000 krads (T_c)	= 25°C unless otherwise noted.	Typical (TYF) values are for reference only.)

Parameter	Symbol	Test Conditions	MIN	ΤΥΡ	ΜΑΧ	Units
Maximum Drain to Source Voltage	V _{DSMAX}	$V_{GS} = 0 V$	300			V
Gate to Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 18 \text{ mA}$	0.8	1.5	2.5	V
Drain to Source Leakage	I _{DSS}	$V_{DS} = 300 \text{ V}, V_{GS} = 0 \text{ V}$		11	400	
Gate to Source Forward Leakage		V _{GS} = 5 V		0.4	600	μA
Gate to Source Reverse Leakage	I _{GSS}	$V_{GS} = -4 V$		5	0.5	-
Drain to Source Resistance (Note 4)	R _{DS(on)}	$I_{\rm D} = 50$ A, $V_{\rm GS} = 5$ V		15	35	mΩ

Typical Single Event Effect Safe Operating Area

Note : All Radiation Single Event Effects testing are performed in heavy ion environments such as the K-500 Cyclotron at Texas A&M.

Test		Envir	V _{DS} Vol	tage (V)		
	lon	LET MeV/mg/cm ²	Range µm	Energy MeV	$V_{GS} = 0 V$	$V_{GS} = -4V$
See SOA	Xe	63	131	1653	300	300
	Au	84.6	130	2482	250	250

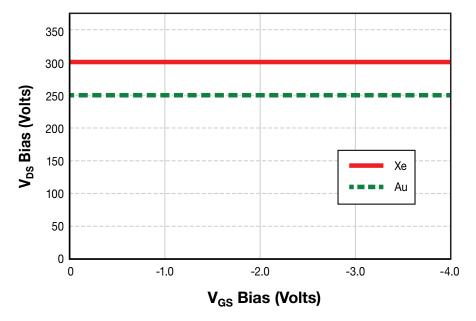
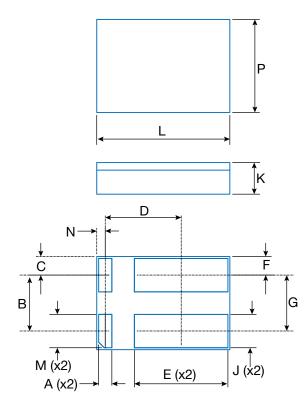


Figure 1: Typical Single Event Effect Safe Operating Area

EPC7030MSH Datasheet

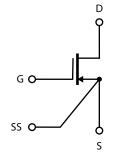
Package Outline and Dimensions



Symbol	Incl	nes	Millim	eters	Note
Cymson	MIN	MAX	MIN	MAX	Note
Α	0.030	0.040	0.76	1.02	
В	0.144	0.154	3.66	3.91	
С	0.0	49	1.2	<u>2</u> 4	REF
D	0.197	0.207	5.00	5.26	
Е	0.244	0.254	6.20	6.45	
F	0.044	0.054	1.12	1.37	
G	0.0	49	1.24		REF
J	0.084	0.094	2.13	2.39	
К	0.076	0.092	1.93	2.34	
L	0.349	0.359	8.86	9.12	
М	0.084	0.094	2.13	2.39	
Ν	0.022		0.8	56	REF
Р	0.243	0.253	6.17	6.43	

Standard Terminal Pad finish is a solder alloy of 63%Sn 37%Pb.

Package Connections



NOTE: SS pin is connected directly to source of internal die.

EPC7030MSH Datasheet

Notes

- Note 1. Never exceed the absolute maximum V_{DS} of the device otherwise permanent damage/destruction may result.
- Note 2. Never exceed the absolute maximum V_{GS} of the device otherwise permanent damage/destruction may result. We recommend a V_{GS} of 5V for optimum operation across life and radiation.
- Note 3. R_{0JA} measured with FSMD-M package mounted to double-sided PCB, 0.063" thickness with 1.0 square inches of copper area on the top (mounting side) and a flood etch (3 square inches) on the bottom side.
- Note 4. Measured using four wire (Kelvin) sensing and pulse measurement techniques. Measurement pulse width is 80 µs and duty cycle is 1%, maximum.
- Note 5. Guaranteed by design/device construction. Not tested.
- Note 6. The gate charge parameters are measured based on the MIL-STD-750.3471 Condition B. A high speed constant gate current (I_{const}) is provided to the Gate of the DUT during the time that the ground switch (G_S) is OFF (t_{off}). The DUT is switched ON and OFF using ground-sensed switch G_S . The gate current is adjusted to yield the desired charge per unit time (I_{const} · time per division) on the measuring oscilloscope. The G_S pulse drive ON time (t_{on}) is adjusted for the desired observability of the gate-source voltage (V_{GS}) waveform. The maximum duty cycle of the ground switch (t_{off} / t_{on}) should be set to 1% maximum. Please note that all gate-related signals are referenced to the "Source Sense" pin on the package. At all times during the measurement, the maximum gate-source voltage is clamped to 5 V_{DC} .

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